

# Single P-channel MOSFET

## ELM4P6115FDA-N

<http://www.elm-tech.com>

### ■General description

ELM4P6115FDA-N uses advanced trench technology to provide excellent  $R_{ds(on)}$ , low gate charge and low gate threshold voltage.

### ■Features

- $V_{ds}=-60V$
- $I_d=35A (V_{gs}=-10V)$
- $R_{ds(on)}=25m\Omega (V_{gs}=-10V)$
- $R_{ds(on)}=33m\Omega (V_{gs}=-4.5V)$

### ■Maximum absolute ratings

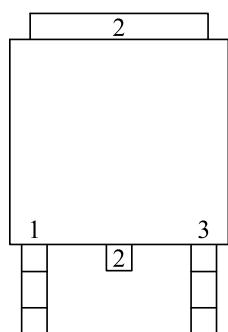
Parameter	Symbol	Limit	Unit	Note
Drain-source voltage	$V_{ds}$	-60	V	
Gate-source voltage	$V_{gs}$	$\pm 20$	V	
Continuous drain current ( $V_{gs}=-10V$ )	$I_d$	-35	A	1
Tc=100°C		-27		
Pulsed drain current	$I_{dm}$	-70	A	2
Single pulse avalanche energy	$E_{as}$	113	mJ	3
Avalanche current	$I_{as}$	47.6	A	
Power dissipation	$P_d$	52.1	W	4
Storage temperature range	$T_{stg}$	-55 to 150	°C	
Operating junction temperature range	$T_j$	-55 to 150	°C	

### ■Thermal characteristics

Parameter	Symbol	Typ.	Max.	Unit	Note
Thermal resistance junction-to-ambient	$R_{\theta ja}$	-	62.0	°C/W	1
Thermal resistance junction-to-case	$R_{\theta jc}$	-	2.4	°C/W	1

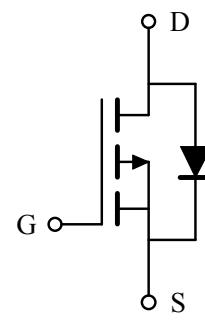
### ■Pin configuration

TO-252(TOP VIEW)



Pin No.	Pin name
1	GATE
2	DRAIN
3	SOURCE

### ■Circuit



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### ■Electrical characteristics

T<sub>j</sub>=25°C. Unless otherwise noted.

Parameter	Symbol	Condition	Min.	Typ.	Max.	Unit	Note
<b>STATIC PARAMETERS</b>							
Drain-source breakdown voltage	BV <sub>dss</sub>	V <sub>gs</sub> =0V, I <sub>d</sub> =-250μA	-60	-	-	V	
Zero gate voltage drain current	Id <sub>ss</sub>	V <sub>ds</sub> =-48V, V <sub>gs</sub> =0V	-	-	-1	μA	
		V <sub>ds</sub> =-48V, V <sub>gs</sub> =0V, T <sub>j</sub> =55°C	-	-	-5		
Gate-body leakage current	I <sub>gss</sub>	V <sub>ds</sub> =0V, V <sub>gs</sub> =±20V	-	-	±100	nA	
Gate threshold voltage	V <sub>gs(th)</sub>	V <sub>ds</sub> =V <sub>gs</sub> , I <sub>d</sub> =-250μA	-1.0	-	-2.5	V	
Static drain-source on-resistance	R <sub>ds(on)</sub>	V <sub>gs</sub> =-10V, I <sub>d</sub> =-18A	-	-	25	mΩ	2
		V <sub>gs</sub> =-4.5V, I <sub>d</sub> =-12A	-	-	33		
Forward transconductance	G <sub>fs</sub>	V <sub>ds</sub> =-10V, I <sub>d</sub> =-18A	-	23	-	S	
Diode forward voltage	V <sub>sd</sub>	I <sub>s</sub> =-1A, V <sub>gs</sub> =0V	-	-	-1	V	2
Continuous source current	I <sub>s</sub>	V <sub>gs</sub> =V <sub>ds</sub> =0V, Force current	-	-	-35	A	1, 5
Pulsed source current	I <sub>sm</sub>		-	-	-70	A	2, 5
<b>DYNAMIC PARAMETERS</b>							
Input capacitance	C <sub>iss</sub>	V <sub>gs</sub> =0V, V <sub>ds</sub> =-15V, f=1MHz	-	3635	-	pF	
Output capacitance	C <sub>oss</sub>		-	224	-	pF	
Reverse transfer capacitance	C <sub>rss</sub>		-	141	-	pF	
Gate resistance	R <sub>g</sub>	V <sub>ds</sub> =0V, V <sub>gs</sub> =0V, f=1MHz	-	7	-	Ω	
<b>SWITCHING PARAMETERS</b>							
Total gate charge (-4.5)	Q <sub>g</sub>	V <sub>gs</sub> =-4.5V, V <sub>ds</sub> =-20V I <sub>d</sub> =-12A	-	25.0	-	nC	
Gate-source charge	Q <sub>gs</sub>		-	6.7	-	nC	
Gate-drain charge	Q <sub>gd</sub>		-	5.5	-	nC	
Turn-on delay time	t <sub>d(on)</sub>	V <sub>gs</sub> =-10V, V <sub>ds</sub> =-15V I <sub>d</sub> =-1A, R <sub>gen</sub> =3.3Ω	-	38.0	-	ns	
Turn-on rise time	t <sub>r</sub>		-	23.6	-	ns	
Turn-off delay time	t <sub>d(off)</sub>		-	100.0	-	ns	
Turn-off fall time	t <sub>f</sub>		-	6.8	-	ns	

#### NOTE :

1. The data tested by surface mounted on a 1 inch<sup>2</sup> FR-4 board with 2OZ copper.
2. The data tested by pulsed, pulse width ≤ 300μs and duty cycle ≤ 2%.
3. The Eas data shows Max. rating . The test condition is V<sub>dd</sub>=-25V, V<sub>gs</sub>=-10V, L=0.1mH, I<sub>as</sub>=-47.6A.
4. The power dissipation is limited by 150°C junction temperature.
5. The data is theoretically the same as I<sub>d</sub> and I<sub>dm</sub>, in real applications, should be limited by total power dissipation.

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## ■Typical electrical and thermal characteristics

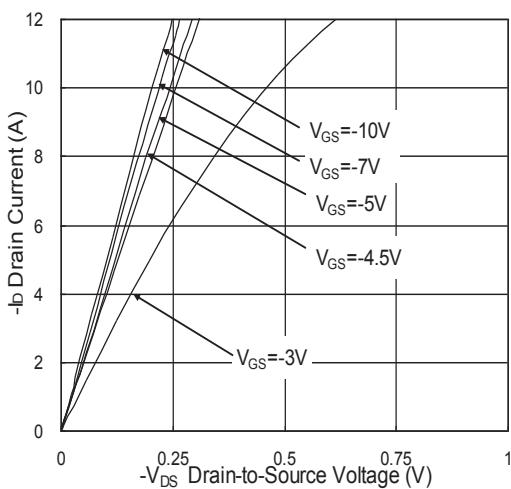


Fig.1 Typical Output Characteristics

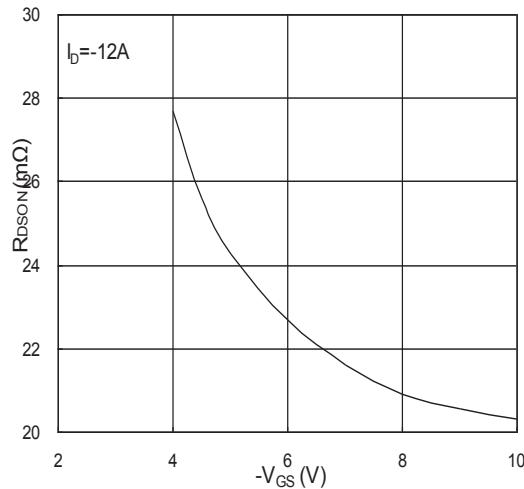


Fig.2 On-Resistance v.s Gate-Source

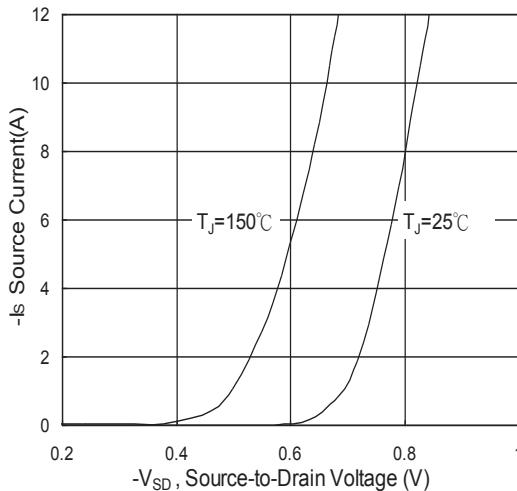


Fig.3 Forward Characteristics Of Reverse

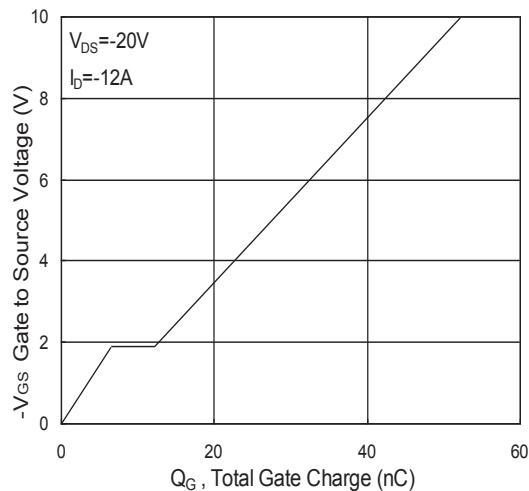


Fig.4 Gate-Charge Characteristics

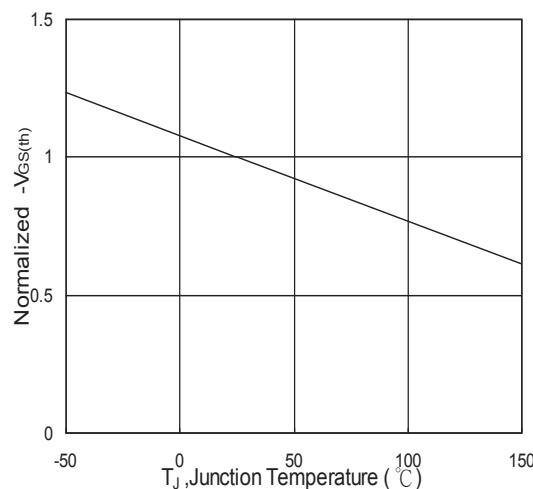


Fig.5 Normalized  $V_{GS(th)}$  v.s  $T_J$

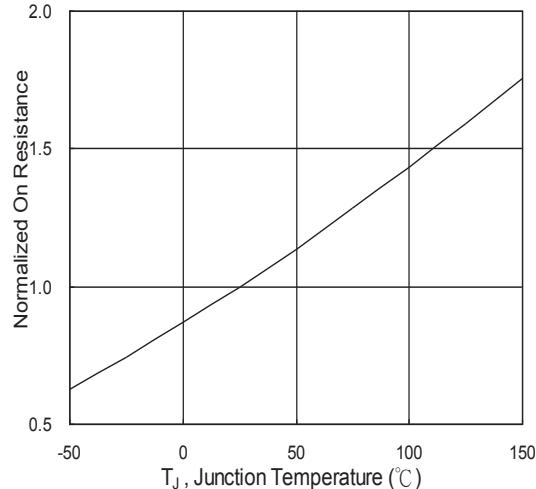


Fig.6 Normalized  $R_{DSON}$  v.s  $T_J$

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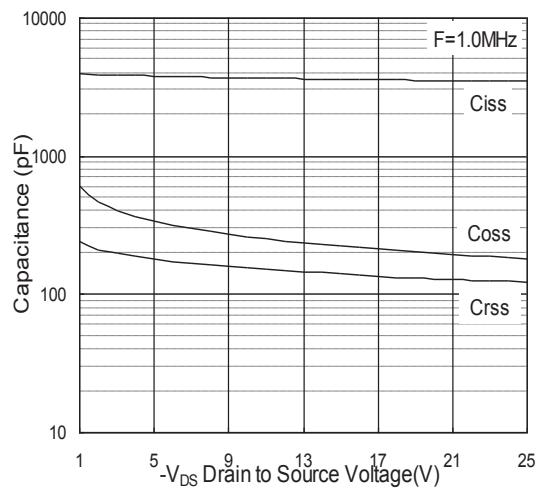


Fig.7 Capacitance

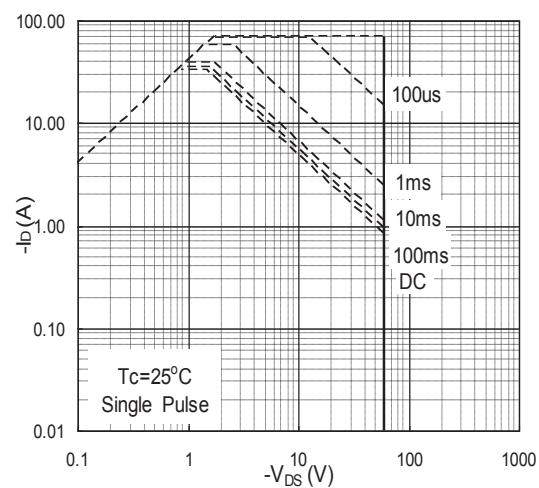


Fig.8 Safe Operating Area

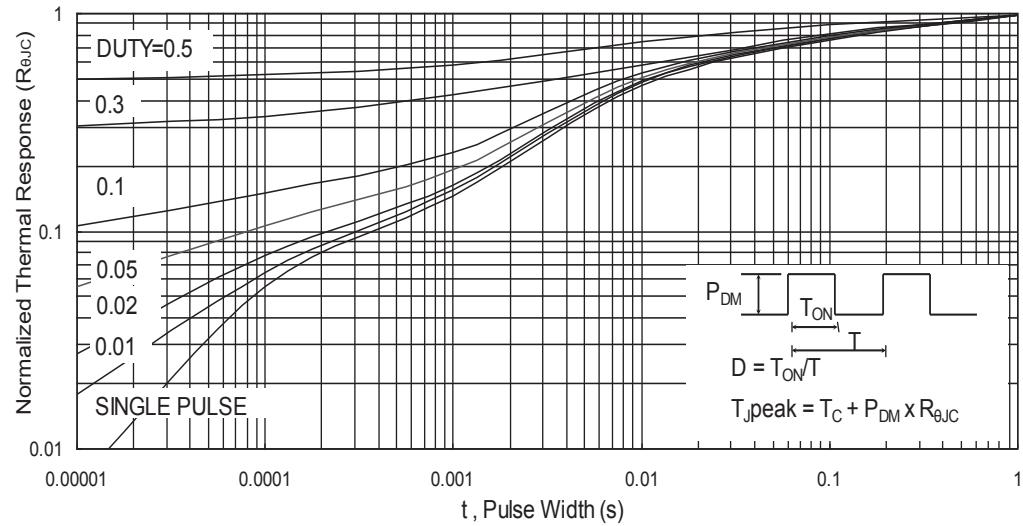


Fig.9 Normalized Maximum Transient Thermal Impedance

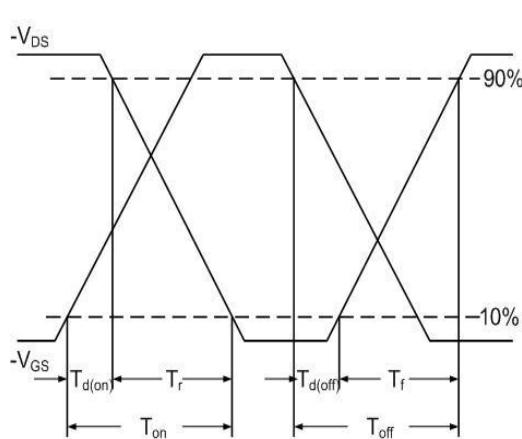


Fig.10 Switching Time Waveform

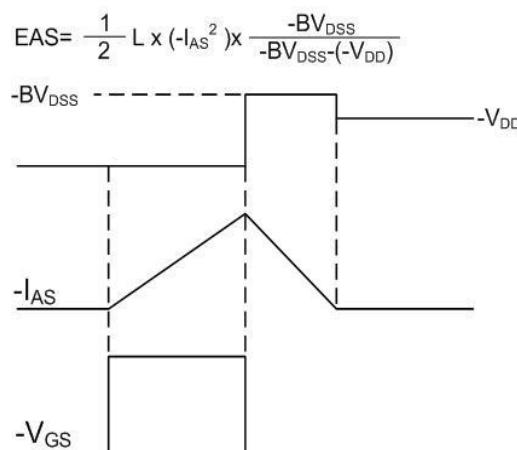


Fig.11 Unclamped Inductive Waveform